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STGW35NB60SD

N-CHANNEL 35A - 600V - TO-247
 Low Drop PowerMESH™ IGBT

General features

Type	V _{CEs}	V _{CE(sat)} (Max) @ 25°C	I _c @ 100°C
STGW35NB60SD	600V	< 1.7V	35A

- LOW ON-VOLTAGE DROP (V_{CEsat})
- LOW INPUT CAPACITANCE
- HIGH CURRENT CAPABILITY

Description

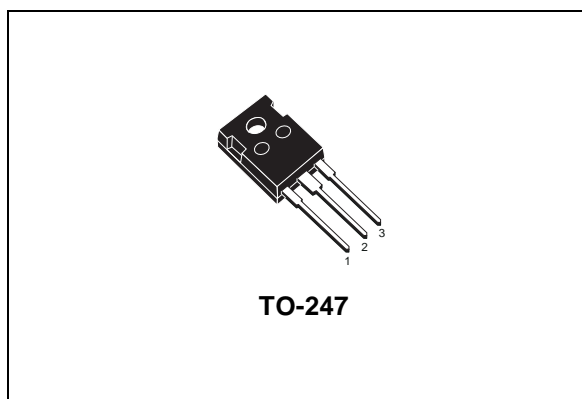
Using the latest high voltage technology based on a patented strip layout, STMicroelectronics has designed an advanced family of IGBTs, the PowerMESH™ IGBTs, with outstanding performances.

Applications

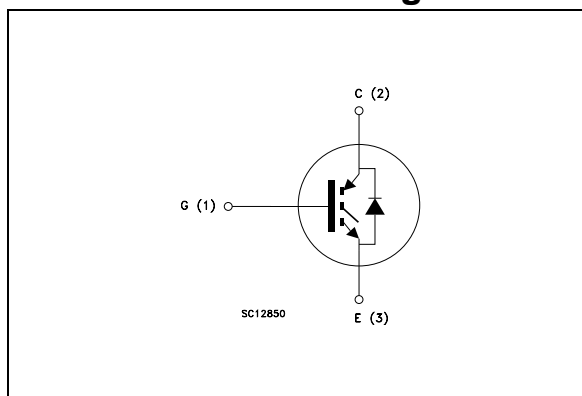
- LIGHT DIMMER
- HID
- WELDING
- MOTOR CONTROL
- STATIC RELAYS

Order codes

Sales Type	Marking	Package	Packaging
STGW35NB60SD	GW35NB60SD	TO-247	TUBE



Internal schematic diagram



1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{CES}	Collector-Emitter Voltage ($V_{GS} = 0$)	600	V
I_C <i>Note 4</i>	Collector Current (continuous) at 25°C	70	A
I_C <i>Note 4</i>	Collector Current (continuous) at 100°C	35	A
I_{CM} <i>Note 1</i>	Collector Current (pulsed)	250	A
V_{GE}	Gate-Emitter Voltage	± 20	V
I_f	Diode RMS Forward Current at $T_C = 25^\circ\text{C}$	30	A
P_{TOT}	Total Dissipation at $T_C = 25^\circ\text{C}$	200	W
T_j	Operating Junction Temperature	- 55 to 150	°C
T_{stg}	Storage Temperature		
T_L	Maximum Lead Temperature for Soldering Purpose (1.6mm from case, for 10sec.)	300	°C

Table 2. Thermal resistance

		Min.	Typ.	Max.	Unit
Rthj-case	Thermal Resistance Junction-case (IGBT)	--	--	0.625	°C/W
Rthj-case	Thermal Resistance Junction-case (DIODE)	--	--	1.5	°C/W
Rthj-amb	Thermal Resistance Junction-ambient	--	--	50	°C/W

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($T_{CASE} = 25\text{ }^{\circ}\text{C}$ unless otherwise specified)

Table 3. Static

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{BR(CES)}$	Collectro-Emitter Breakdown Voltage	$I_C = 1\text{mA}, V_{GE} = 0$	600			V
$V_{CE(SAT)}$	Collector-Emitter Saturation Voltage	$V_{GE} = 15\text{V}, I_C = 20\text{A}, T_j = 25^{\circ}\text{C}$ $V_{GE} = 15\text{V}, I_C = 20\text{A}, T_j = 125^{\circ}\text{C}$		1.25 1.2	1.7	V V
$V_{GE(th)}$	Gate Threshold Voltage	$V_{CE} = V_{GE}, I_C = 250\mu\text{A}$	2.5		5	V
I_{CES}	Collector-Emitter Leakage Current ($V_{GE} = 0$)	$V_{CE} = \text{Max Rating}, T_c = 25^{\circ}\text{C}$ $V_{CE} = \text{Max Rating}, T_c = 125^{\circ}\text{C}$			10 100	μA μA
I_{GES}	Gate-Emitter Leakage Current ($V_{CE} = 0$)	$V_{GE} = \pm 20\text{V}, V_{CE} = 0$			± 100	nA
g_{fs}	Forward Transconductance	$V_{CE} = 10\text{V}, I_C = 18\text{A}$		20		S

Table 4. Dynamic

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
C_{ies}	Input Capacitance	$V_{CE} = 25\text{V}, f = 1\text{ MHz}, V_{GE} = 0$		1820		pF
C_{oes}	Output Capacitance			167		pF
C_{res}	Reverse Transfer Capacitance			27		pF
Q_g	Total Gate Charge	$V_{CE} = 480\text{V}, I_C = 20\text{A},$ $V_{GE} = 15\text{V},$ (see Figure 17)		83	115	nC
Q_{ge}	Gate-Emitter Charge			10		nC
Q_{gc}	Gate-Collector Charge			27		nC
I_{CL}	Turn-Off SOA Minimum Current	$V_{clamp} = 480\text{V}, T_j = 125^{\circ}\text{C}$ $R_G = 100\Omega$	80			A

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Table 5. Switching on/off (inductive load)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$ t_r $(di/dt)_{on}$	Turn-on Delay Time Current Rise Time Turn-on Current Slope	$V_{CC} = 480V, I_C = 20A$ $R_G = 100\Omega, V_{GE} = 15V, T_j = 25^\circ C$ (see Figure 3)		92 70 340		ns ns A/ μs
$t_{d(on)}$ t_r $(di/dt)_{on}$	Turn-on Delay Time Current Rise Time Turn-on Current Slope	$V_{CC} = 480V, I_C = 20A$ $R_G = 100\Omega, V_{GE} = 15V, T_j = 125^\circ C$ (see Figure 3)		80 73 320		ns ns A/ μs
$t_r(V_{off})$ $t_{d(off)}$ t_f	Off Voltage Rise Time Turn-off Delay Time Current Fall Time	$V_{CC} = 480V, I_C = 20A,$ $R_{GE} = 100\Omega, V_{GE} = 5V, T_j = 25^\circ C$ (see Figure 18)		0.78 1.1 0.79		μs μs μs
$t_r(V_{off})$ $t_{d(off)}$ t_f	Off Voltage Rise Time Turn-off Delay Time Current Fall Time	$V_{CC} = 480V, I_C = 20A,$ $R_{GE} = 100\Omega, V_{GE} = 15V, T_j = 125^\circ C$ (see Figure 18)		1.1 2.4 1.2		μs μs μs

Table 6. Switching energy (inductive load)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
E_{on} <i>Note 2</i> E_{off} <i>Note 3</i> E_{ts}	Turn-on Switching Losses Turn-off Switching Losses Total Switching Losses	$V_{CC} = 480V, I_C = 20A$ $R_G = 100\Omega, V_{GE} = 15V, T_j = 25^\circ C$ (see Figure 18)		0.84 7.4 8.24		mJ mJ mJ
E_{on} <i>Note 2</i> E_{off} <i>Note 3</i> E_{ts}	Turn-on Switching Losses Turn-off Switching Losses Total Switching Losses	$V_{CC} = 480V, I_C = 20A$ $R_G = 100\Omega, V_{GE} = 15V, T_j = 125^\circ C$ (see Figure 18)		0.86 11.5 12.4		mJ mJ mJ

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Table 7. Collector-emitter diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V_f	Forward On-Voltage	$I_f = 10A$ $I_f = 10A, T_j = 125^\circ C$		1.3 1	2	V V
t_{rr} t_a Q_{rr} I_{rrm} S	Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Current Softness factor of the diode	$I_f = 20A, V_R = 40V,$ $T_j = 25^\circ C, di/dt = 100A/\mu s$ (see Figure 19)		44 32 66 3 0.375		ns ns nC A
t_{rr} t_a Q_{rr} I_{rrm} S	Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Current Softness factor of the diode	$I_f = 20A, V_R = 40V,$ $T_j = 125^\circ C, di/dt = 100A/\mu s$ (see Figure 19)		88 56 237 5.4 0.57		ns ns nC A

(1) Pulse width limited by max. junction temperature

(2) E_{on} is the turn-on losses when a typical diode is used in the test circuit in figure 2. E_{on} include diode recovery energy. If the IGBT is offered in a package with a co-pak diode, the co-pak diode is used as external diode. IGBTs & Diode are at the same temperature (25°C and 125°C)

(3) Turn-off losses include also the tail of the collector current

(4) Calculated according to the iterative formula:

$$I_C(T_C) = \frac{T_{JMAX} - T_C}{R_{THJ-C} \times V_{CESAT(MAX)}(T_C, I_C)}$$

2.1 Electrical characteristics (curves)

Figure 1. Output Characteristics

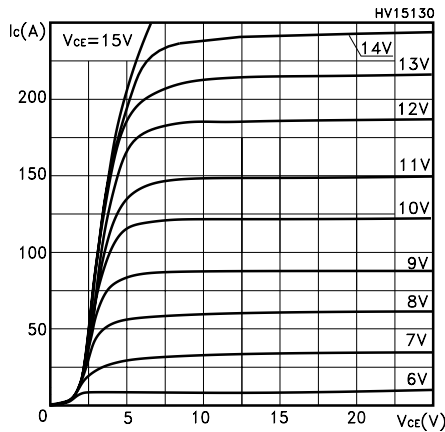


Figure 2. Transfer Characteristics

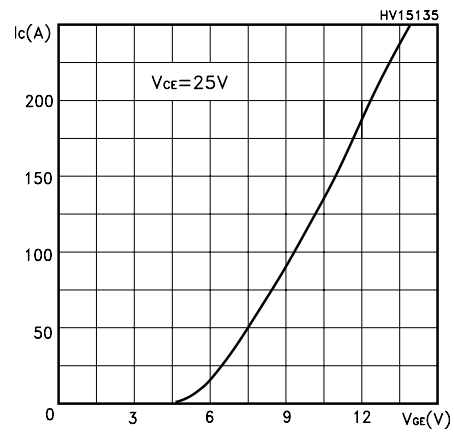


Figure 3. Transconductance

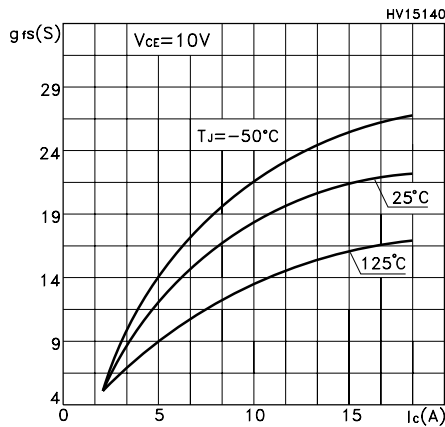


Figure 4. Normalized Collector-Emitter On Voltage vs Temperature

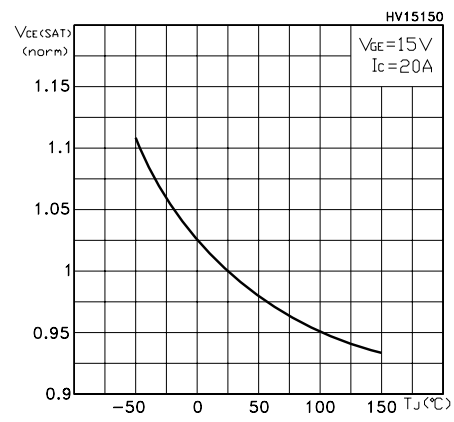


Figure 5. Collector-Emitter on Voltage vs Collector Current

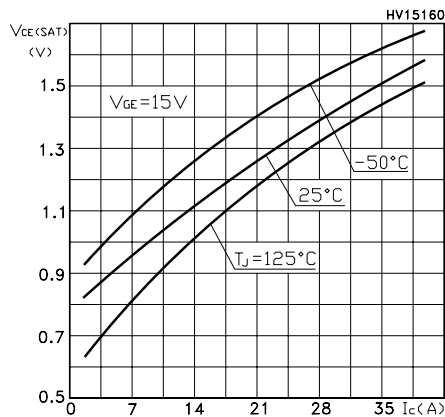
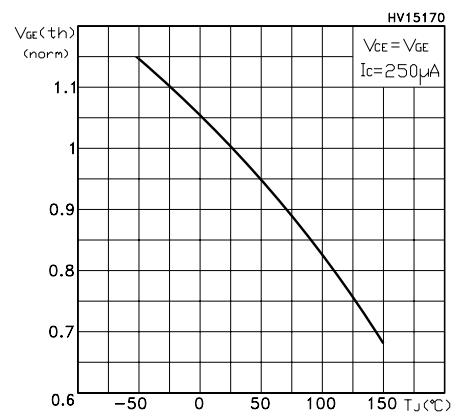


Figure 6. Gate Threshold vs Temperature



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Figure 7. Normalized Breakdown Voltage vs Temperature

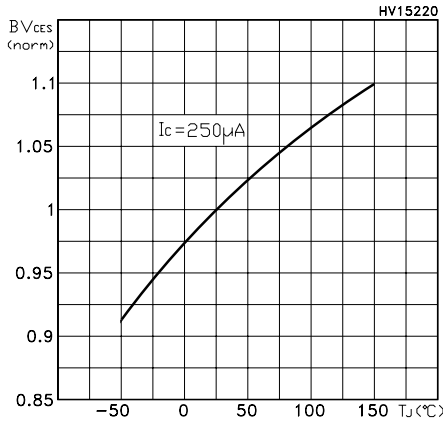


Figure 8. Gate Charge vs Gate-Emitter Voltage

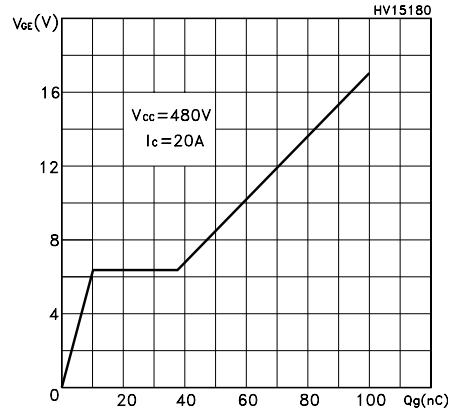


Figure 9. Capacitance Variations

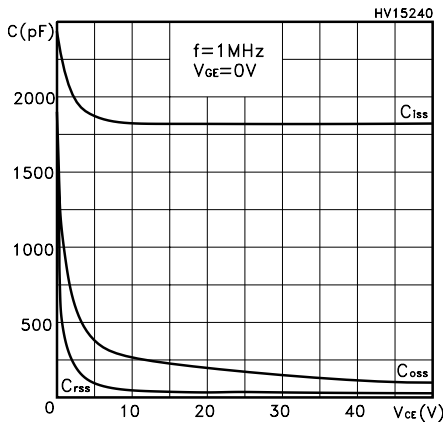


Figure 10. Switching Losses vs Gate Charge

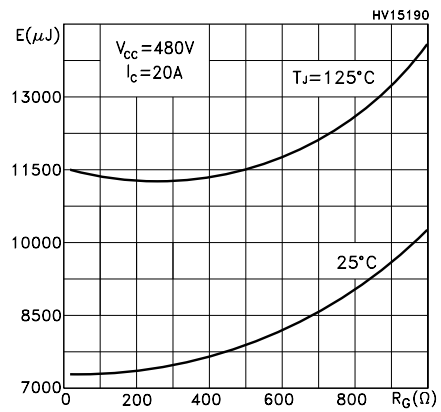


Figure 11. Switching Losses vs Temperature

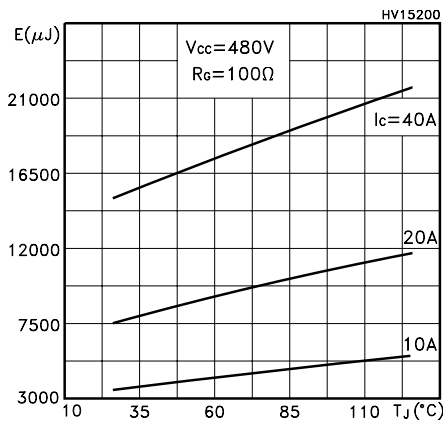
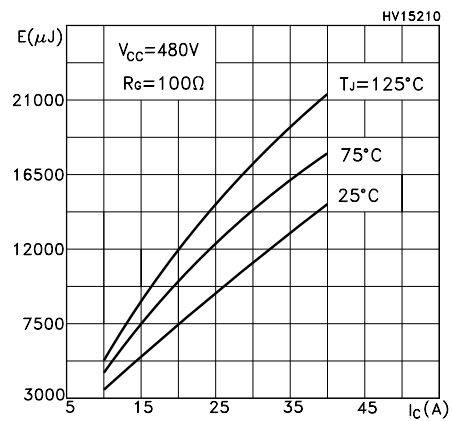


Figure 12. Switching Losses vs Collector Current



2 Electrical characteristics

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Figure 13. Thermal Impedance

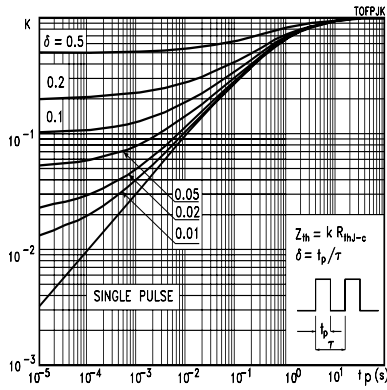


Figure 14. Turn-Off SOA

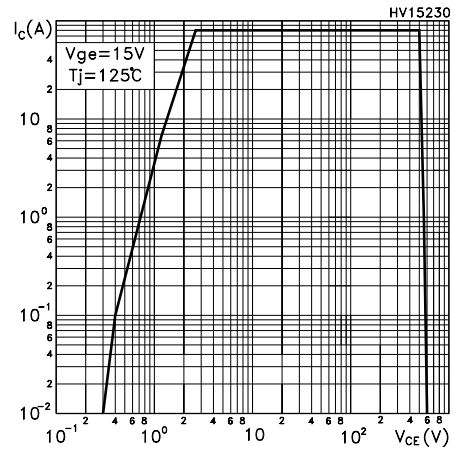
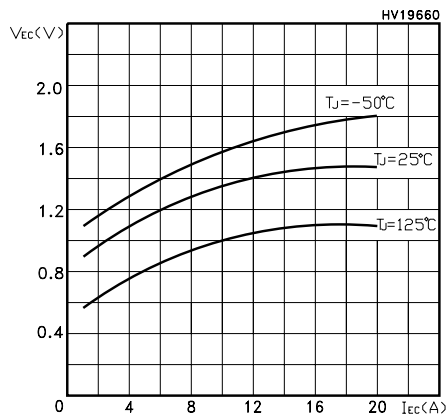


Figure 15. Emitter-Collector Diode Characteristics



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3 Test Circuits

3 Test Circuits

Figure 16. Test Circuit for Inductive Load Switching

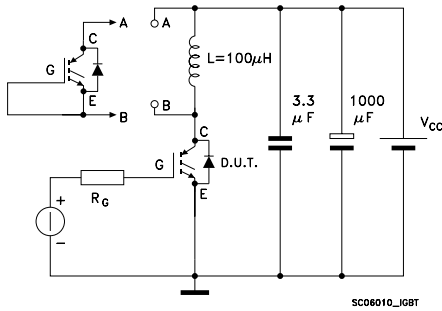


Figure 17. Gate Charge Test Circuit

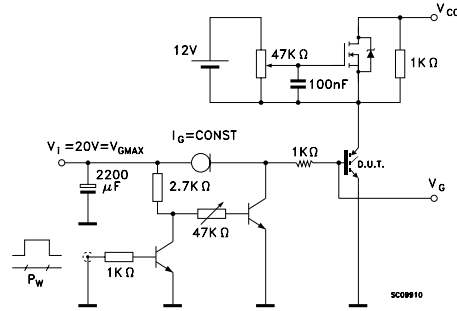


Figure 18. Switching Waveform

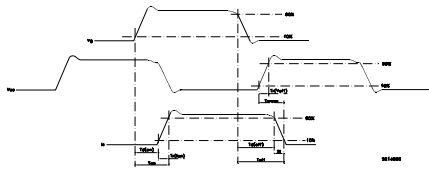
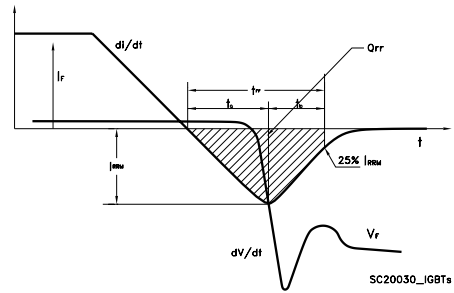


Figure 19. Diode Recovery Time Waveform



4 Package mechanical data

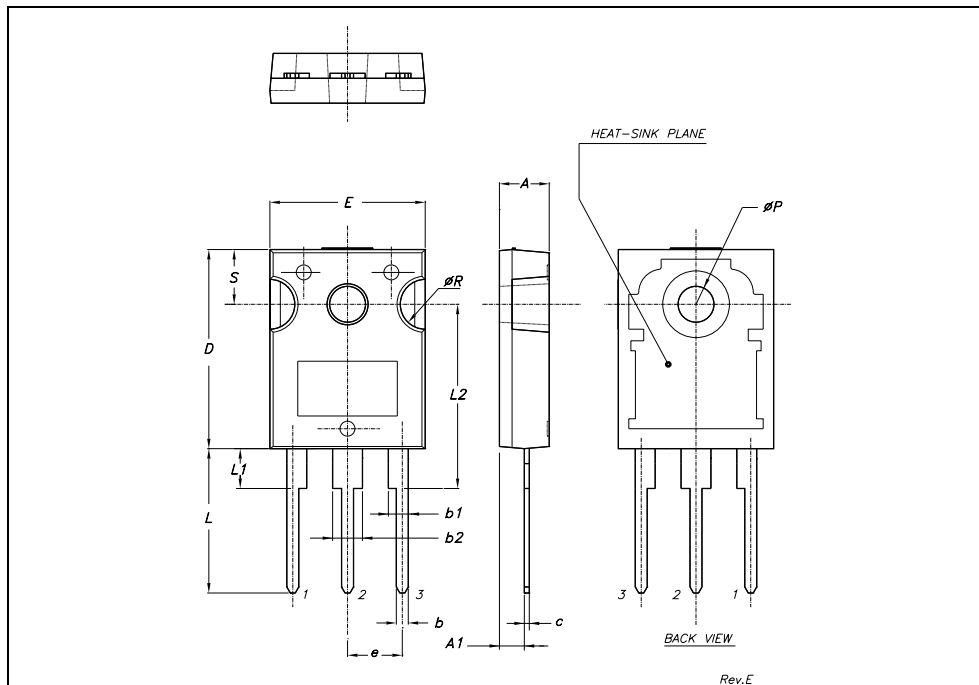
In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

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4 Package mechanical data

TO-247 MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A	4.85		5.15	0.19		0.20
A1	2.20		2.60	0.086		0.102
b	1.0		1.40	0.039		0.055
b1	2.0		2.40	0.079		0.094
b2	3.0		3.40	0.118		0.134
c	0.40		0.80	0.015		0.03
D	19.85		20.15	0.781		0.793
E	15.45		15.75	0.608		0.620
e		5.45			0.214	
L	14.20		14.80	0.560		0.582
L1	3.70		4.30	0.14		0.17
L2		18.50			0.728	
øP	3.55		3.65	0.140		0.143
øR	4.50		5.50	0.177		0.216
S		5.50			0.216	



5 Revision History

Date	Revision	Changes
16-Nov-2005	1	Initial release.

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5 Revision History

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